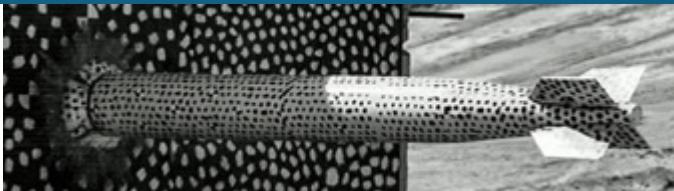
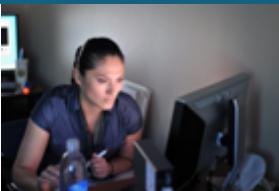




Sandia  
National  
Laboratories

# X-ray image acquisition of a device undergoing pyroshock

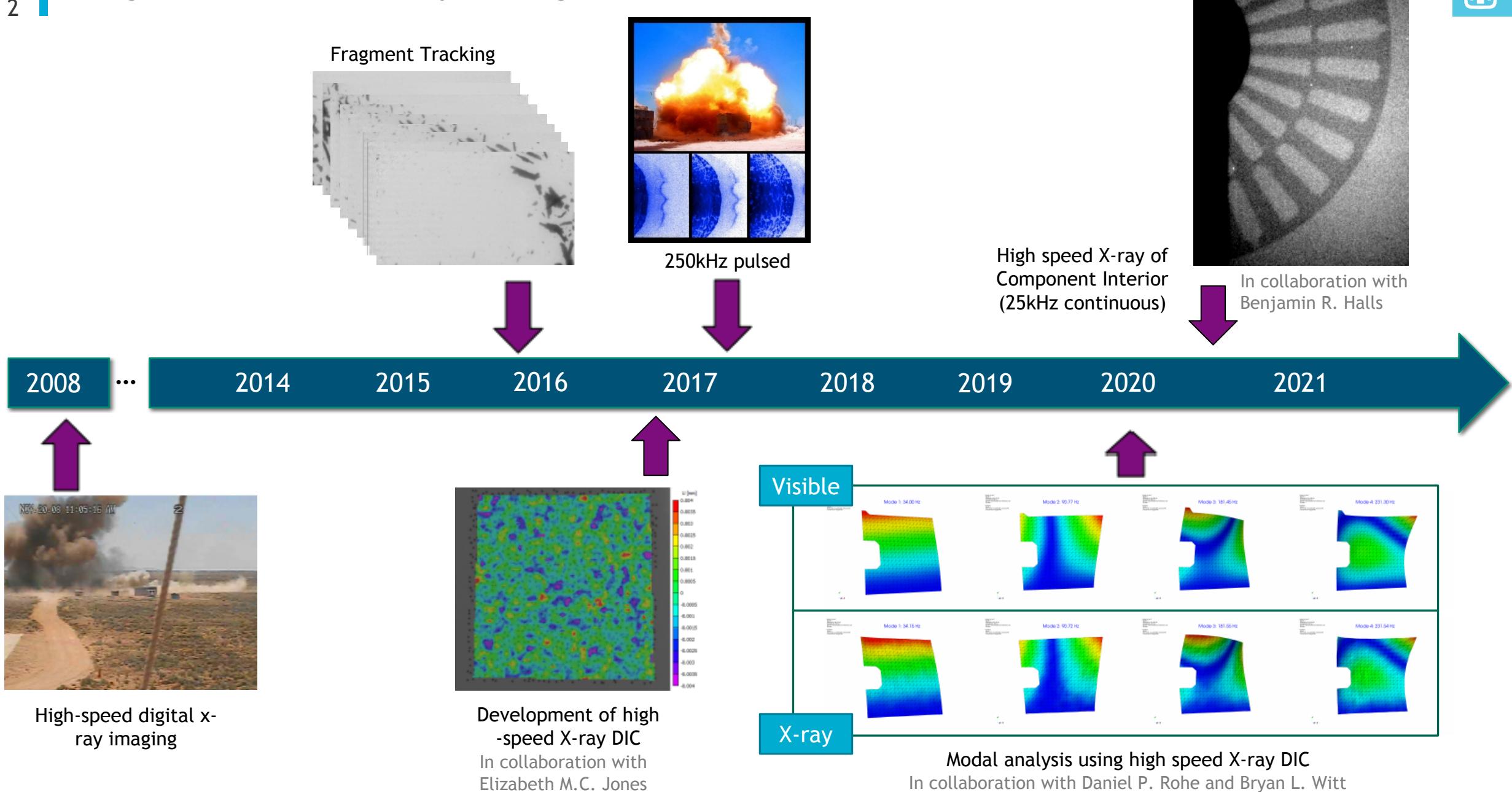


*Robert Waymel, Enrico C. Quintana, Phillip L. Reu, Kyle R. Thompson, Andrew Lentfer, Gabriella Dalton, and Thomas L. Martinez*



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# High Speed X-ray Diagnostic Development



# X-ray Equipment



Varian 150 keV X-ray tube w/ collimator

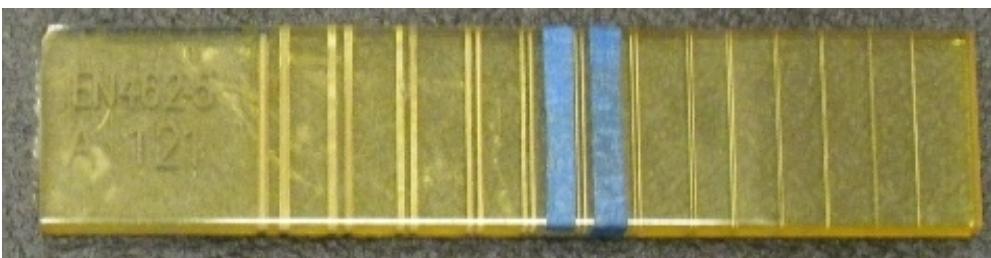
- Image contrast directly correlated to volta
- 400 micron spot size (affects image sharpness)

GOS:Pr scintillator

- Rapidly decays visible light (4-7  $\mu$ s)
- Phantom v2512

Setup tools

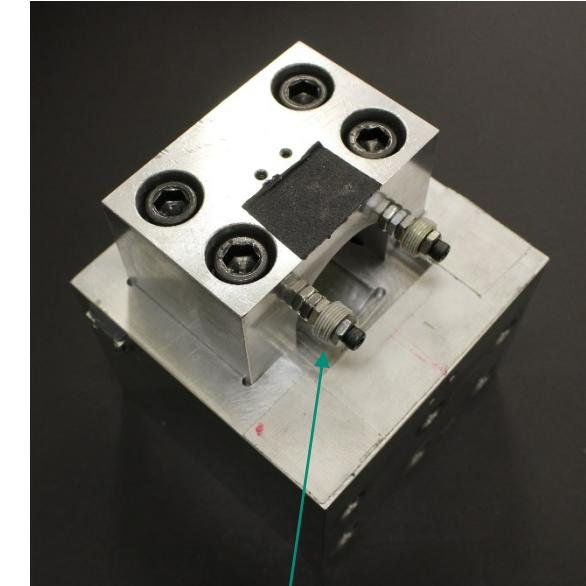
- X-ray source/detector alignment
- Line-pair gage (resolvable feature)
- Calibration grid (spatial resolution)



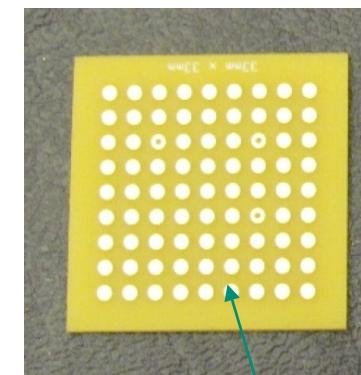
Line-Pair Gage



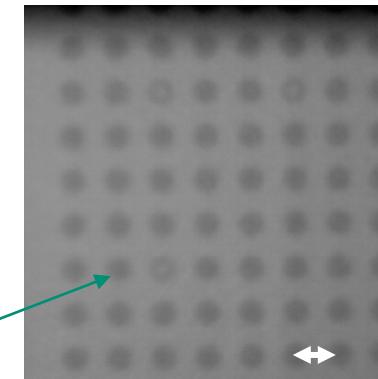
Source w/ collimator



Alignment tool



Calibration Grid



Uniform Spacing

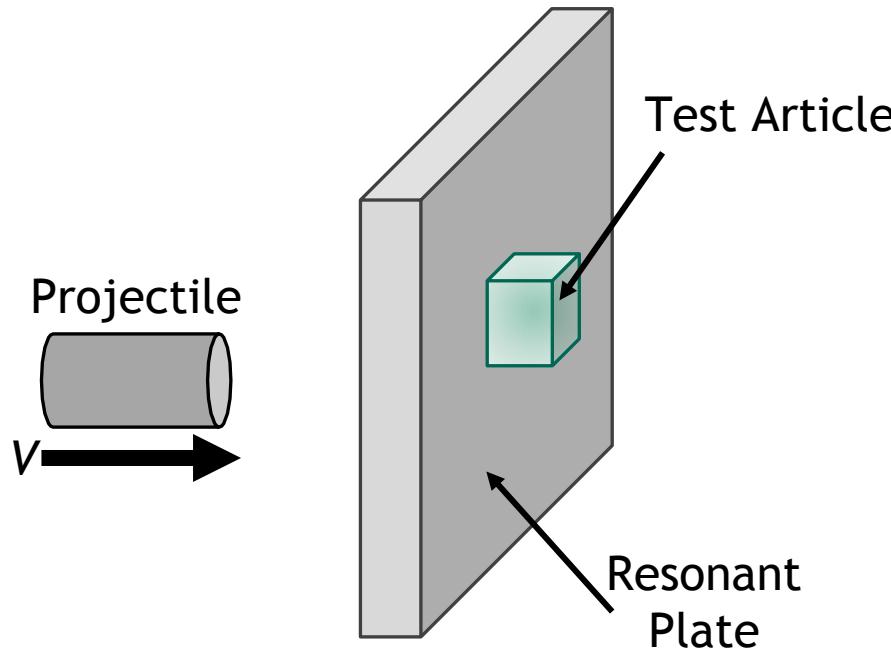
# Resonant Plate Testing



Simulates mid-field and far-field shock events

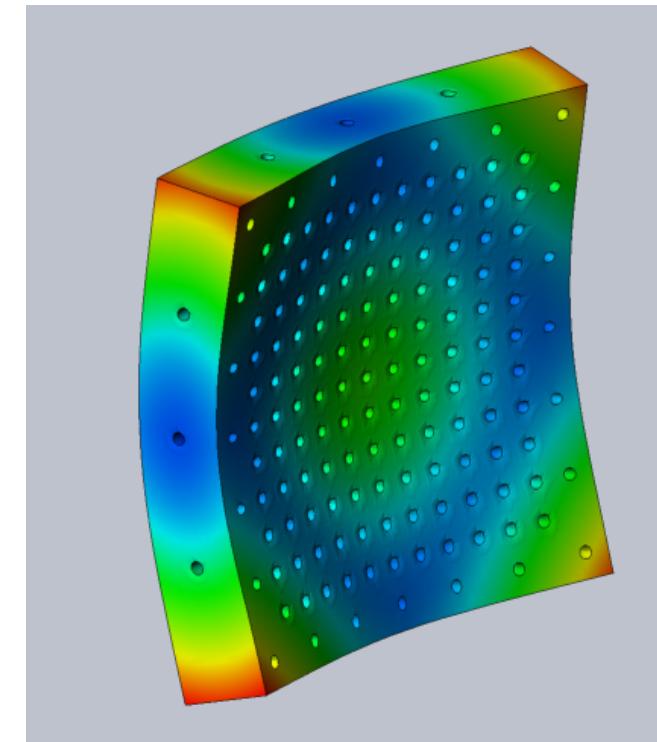
Excites 3<sup>rd</sup> natural frequency of a free-free square plate

- “Breathing,” “drum-head,” “oil-canning”

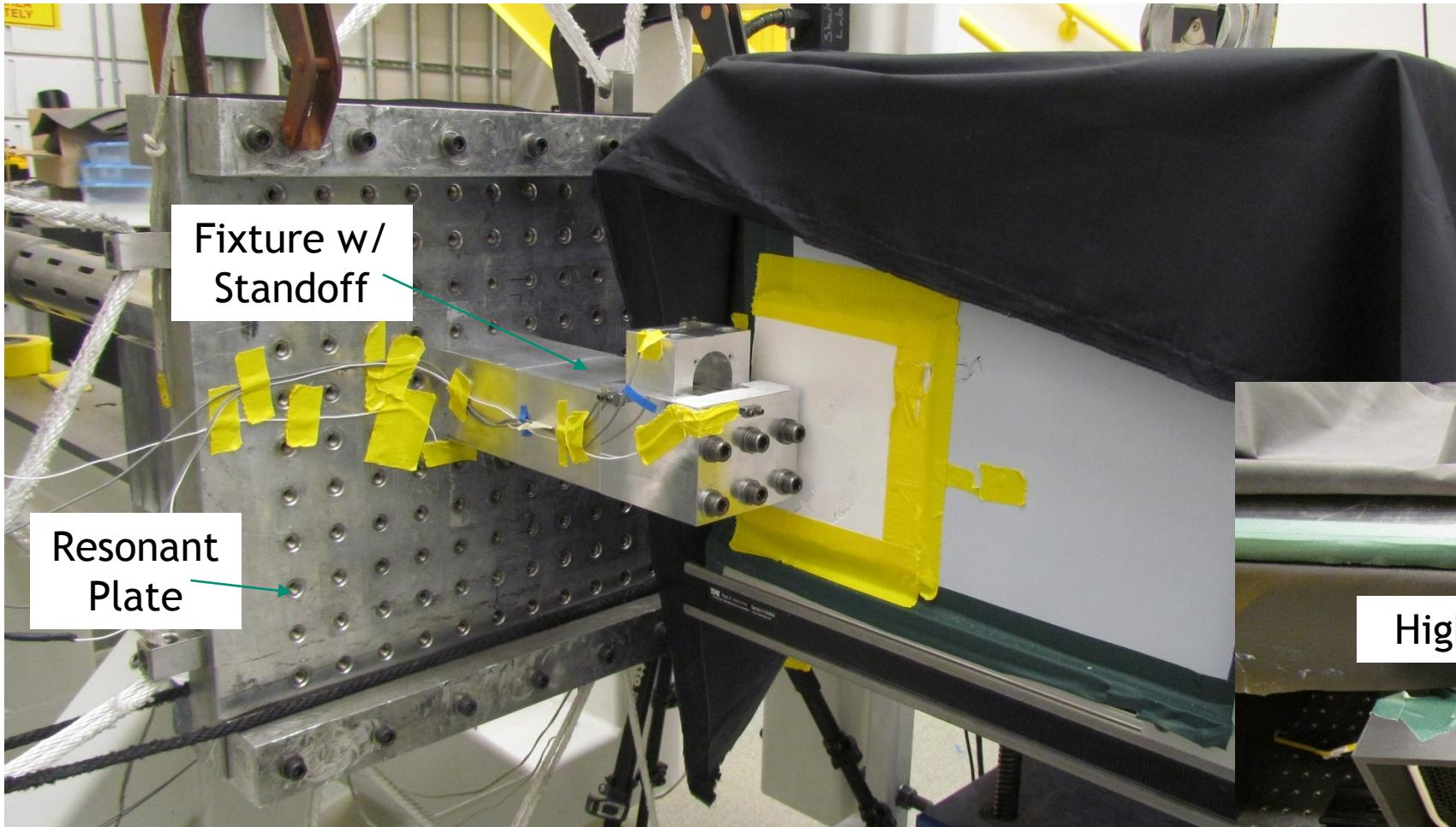


Region	Acceleration Amplitude (g)	Frequency (Hz)
Near-Field	>10,000	>10,000
Mid-Field	<10,000	3,000-10,000
Far-Field	<1,000	<3,000

MIL-STD-810H, Method 517 (2019)



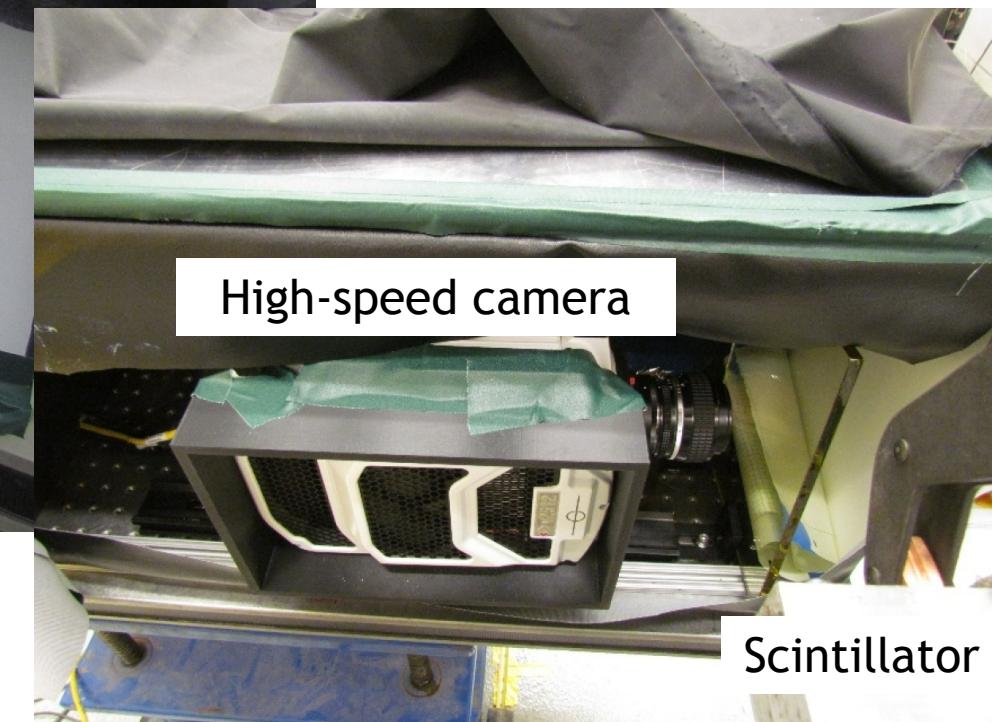
# High-speed X-ray/Pyroshock Test Setup



Resonant plate w/  
damping bars

Offset fixture

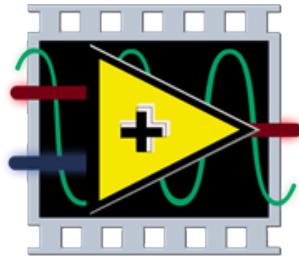
Signals synchronized  
w/ Stanford Signal  
Generator



# Image Analysis



Identify the relative motion between three pairs of surfaces (denoted A, B, and C)



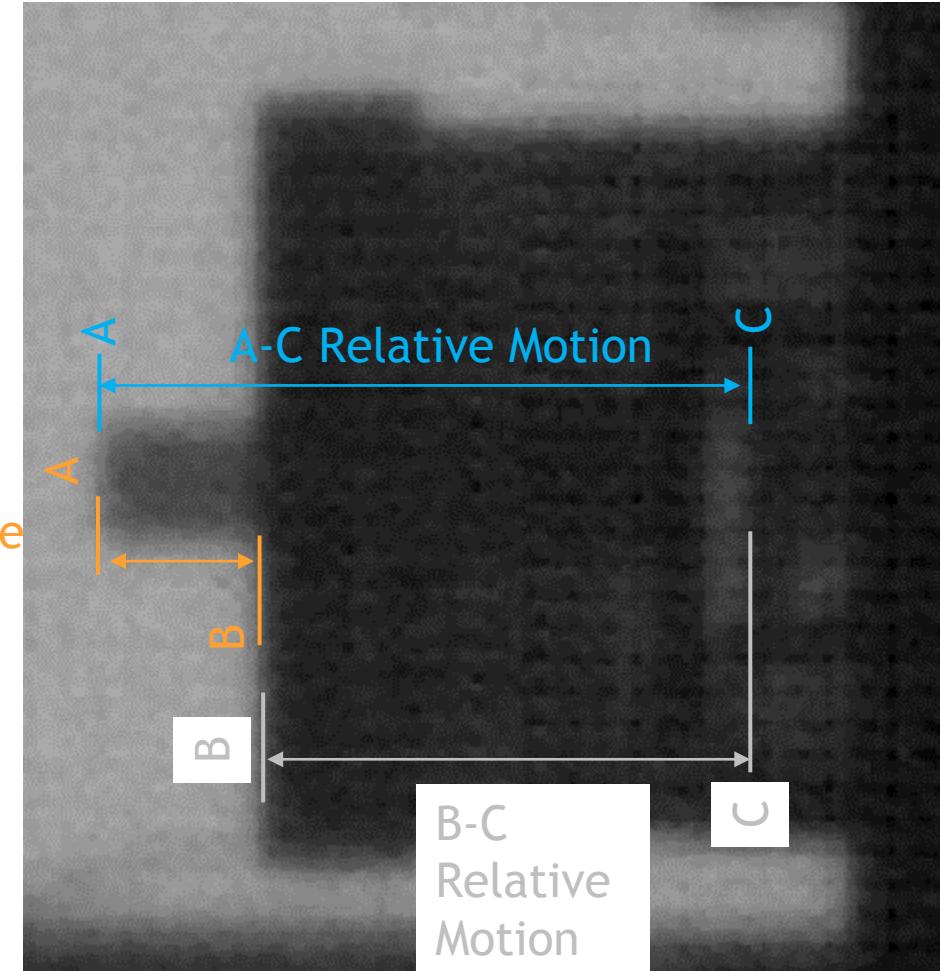
# LabVIEW

Remove rigid body motion

Noise reduction

- Temporal filtering (average several frames)
- Gaussian spatial filtering

Generic edge tracking algorithm in LabView



# Typical Behavior During Shock

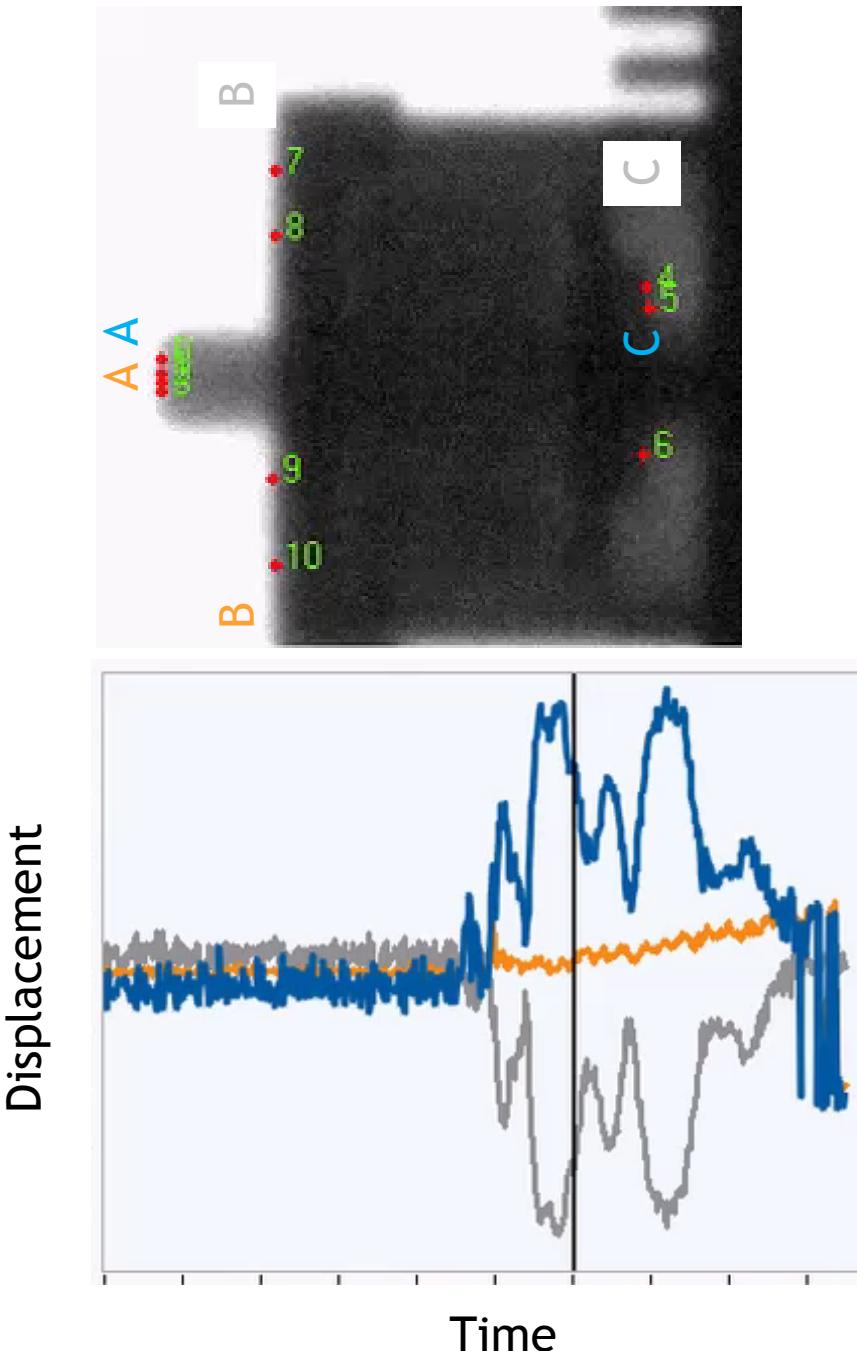


Possible to determine displacement from images

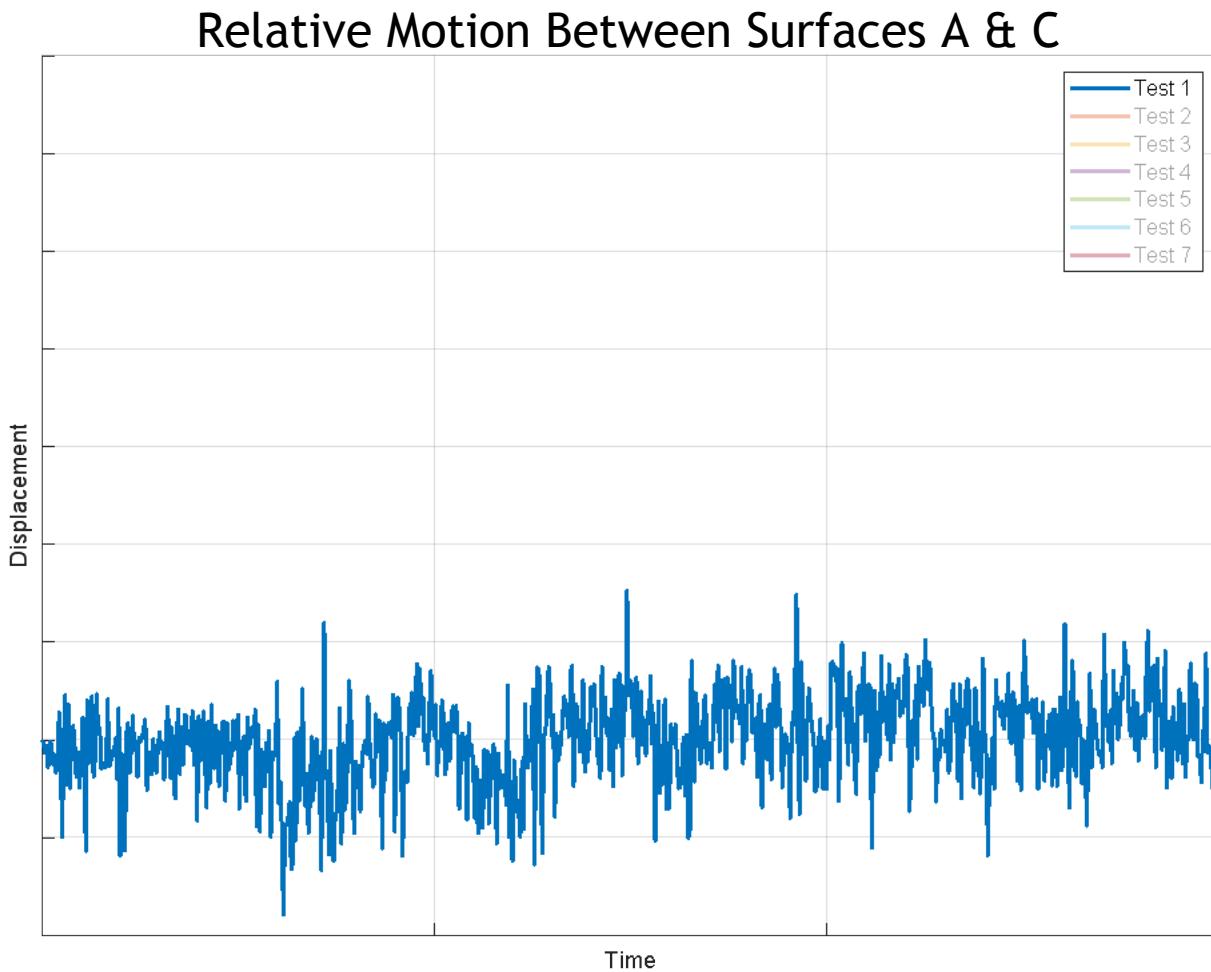
Average multiple points on a surface

Displacement resolved on order of mils

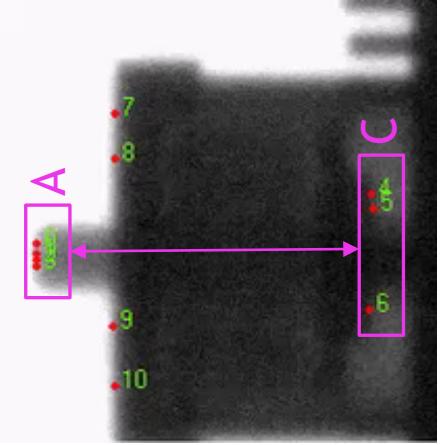
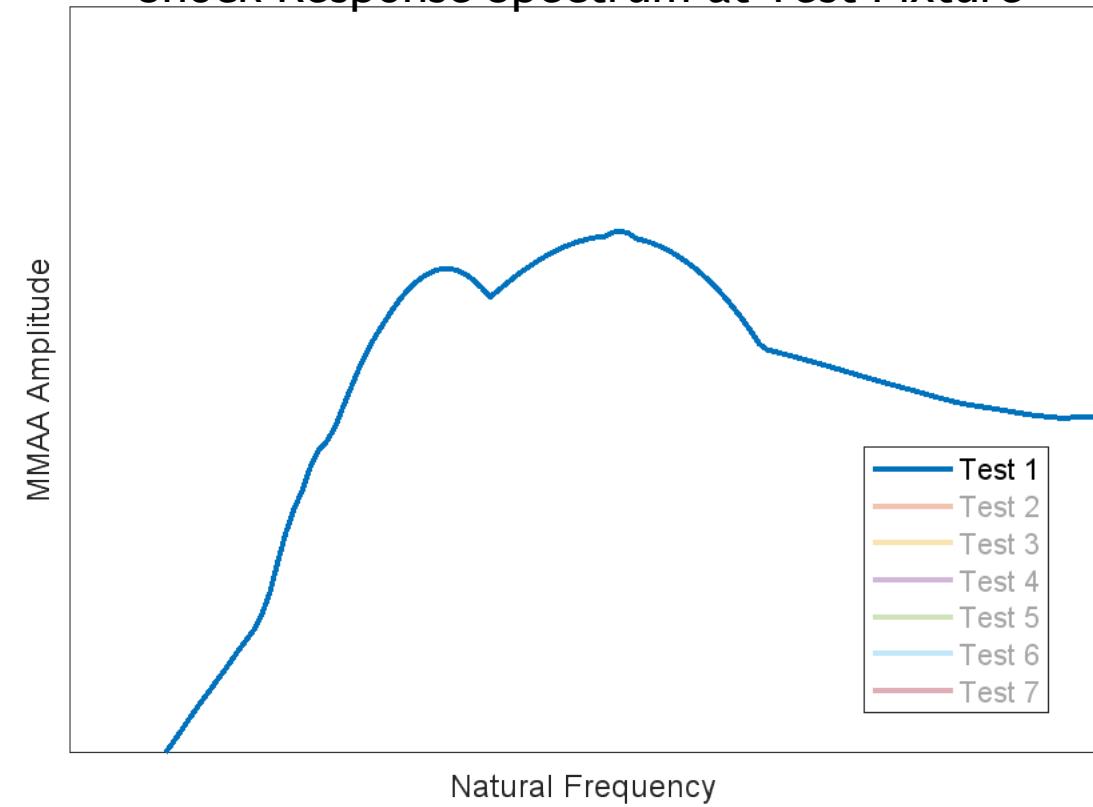
Image rate: 25 kHz (image every 40 microseconds)



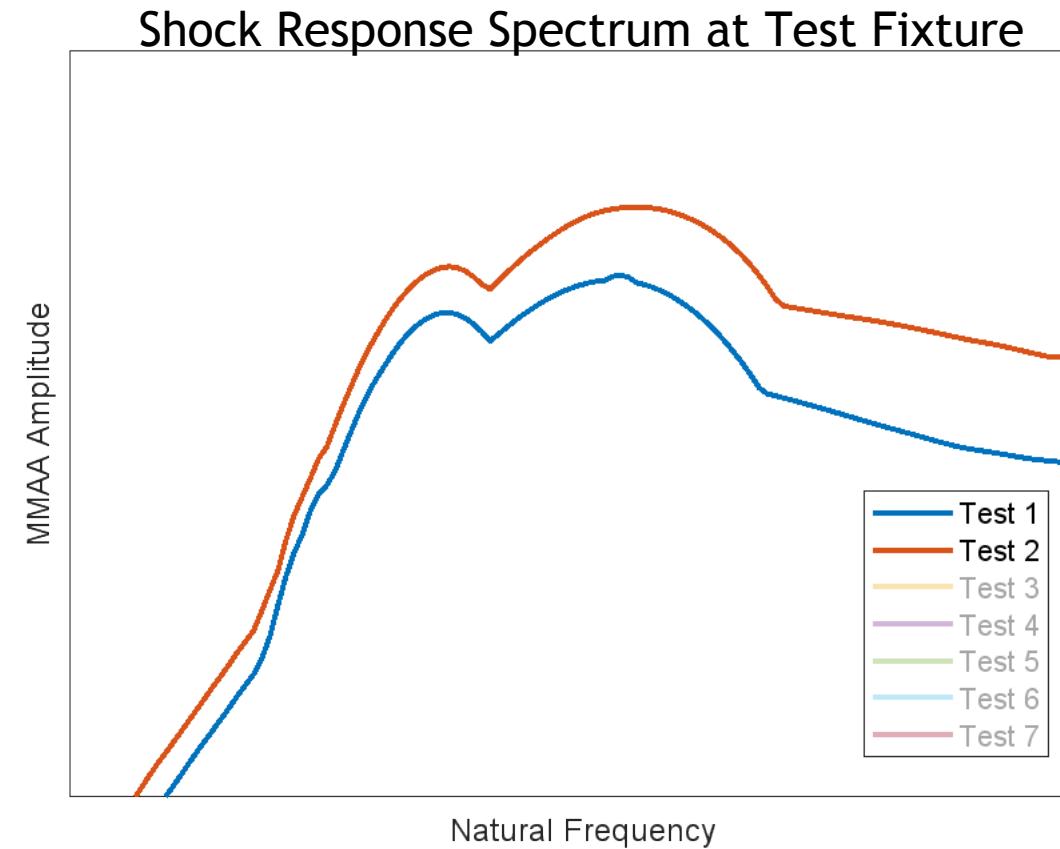
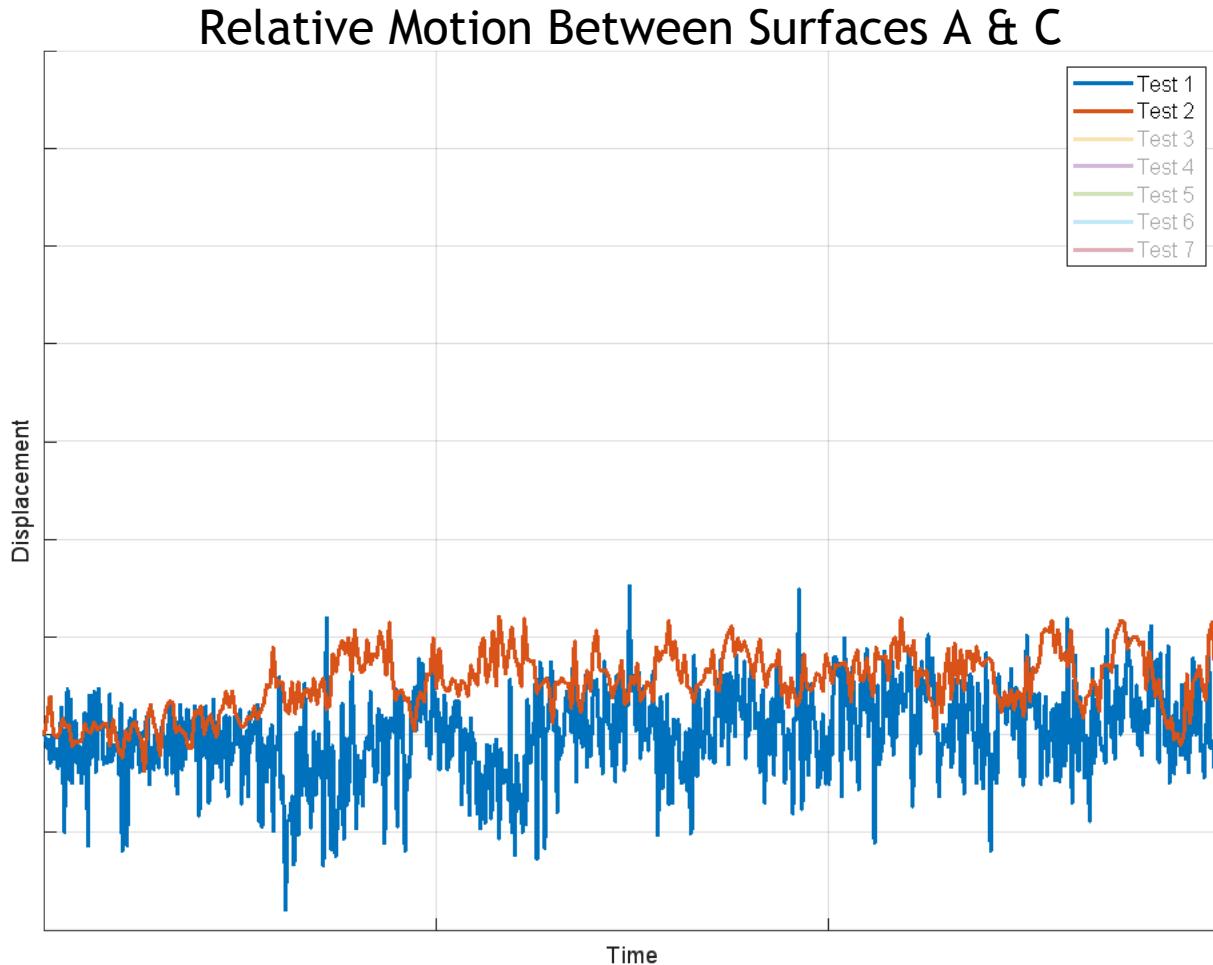
# Monitoring Displacements at Different Input Levels



Shock Response Spectrum at Test Fixture



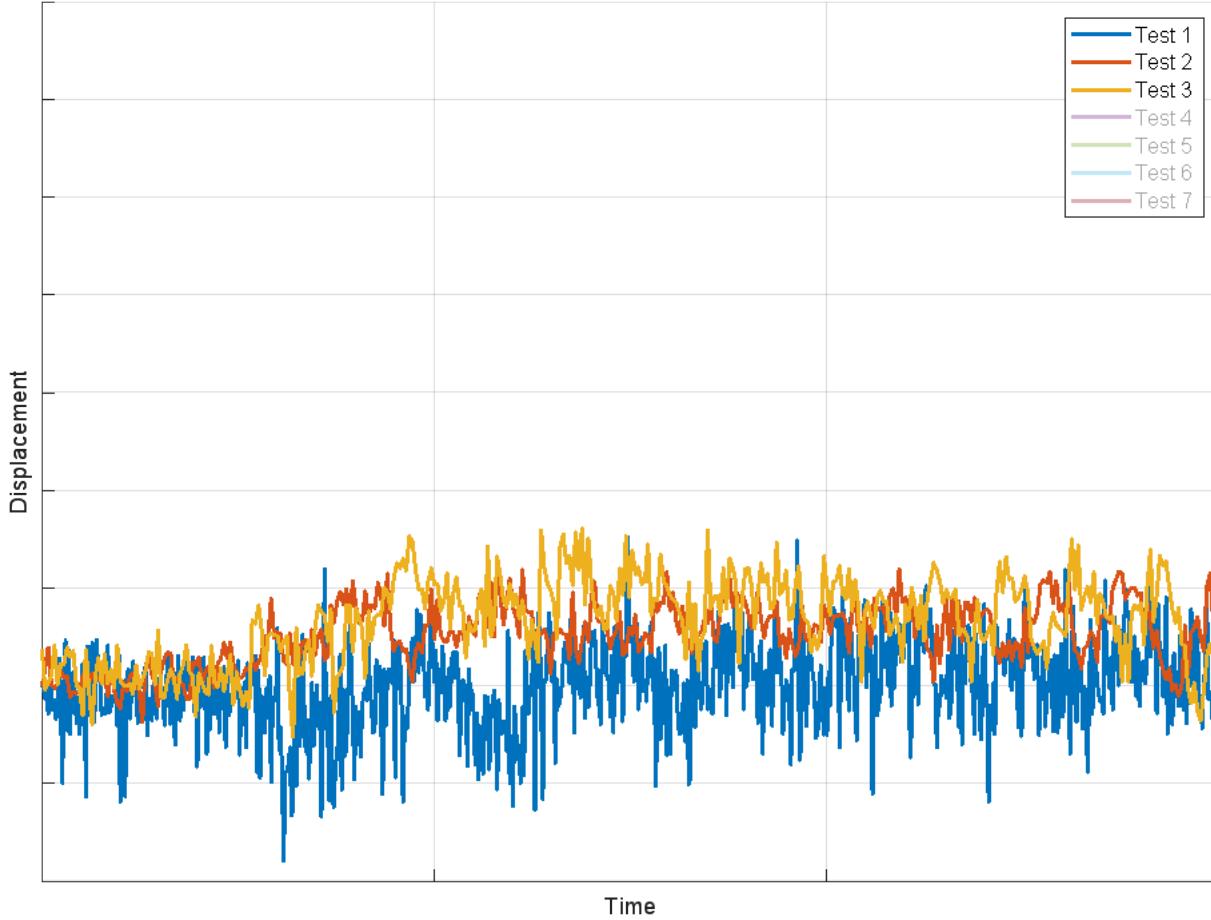
# 9 Monitoring Displacements at Different Input Levels



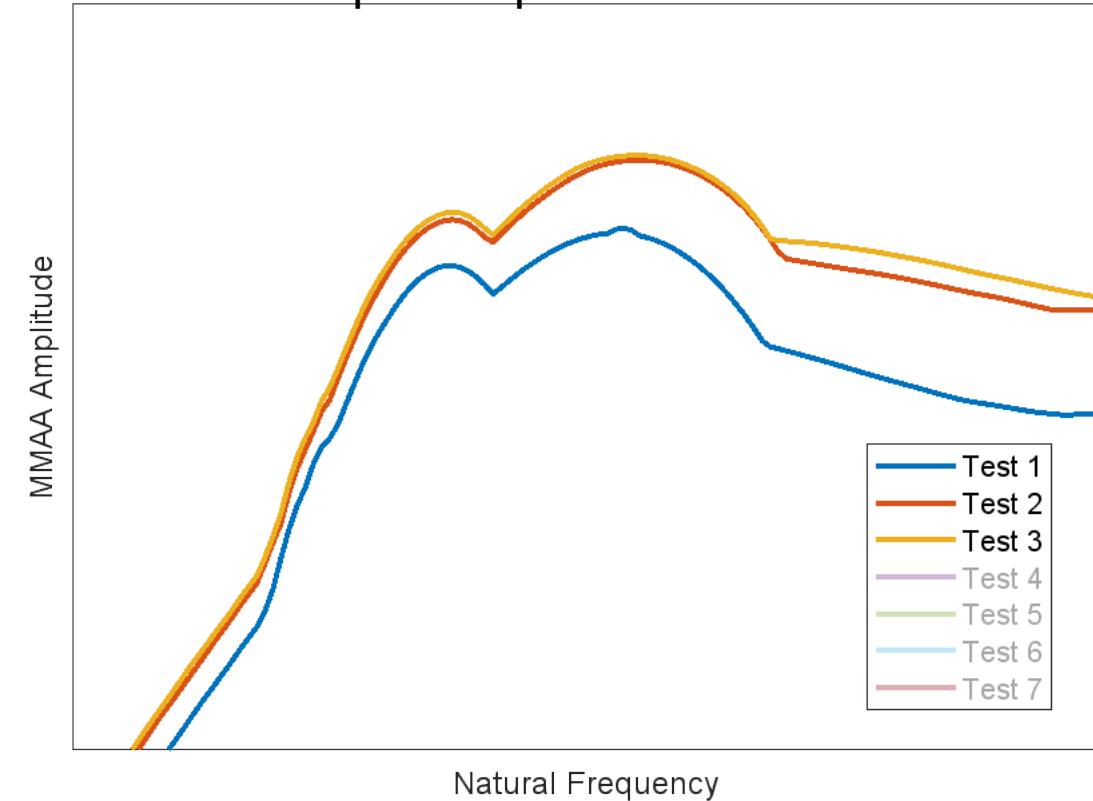
# Monitoring Displacements at Different Input Levels



Relative Motion Between Surfaces A & C



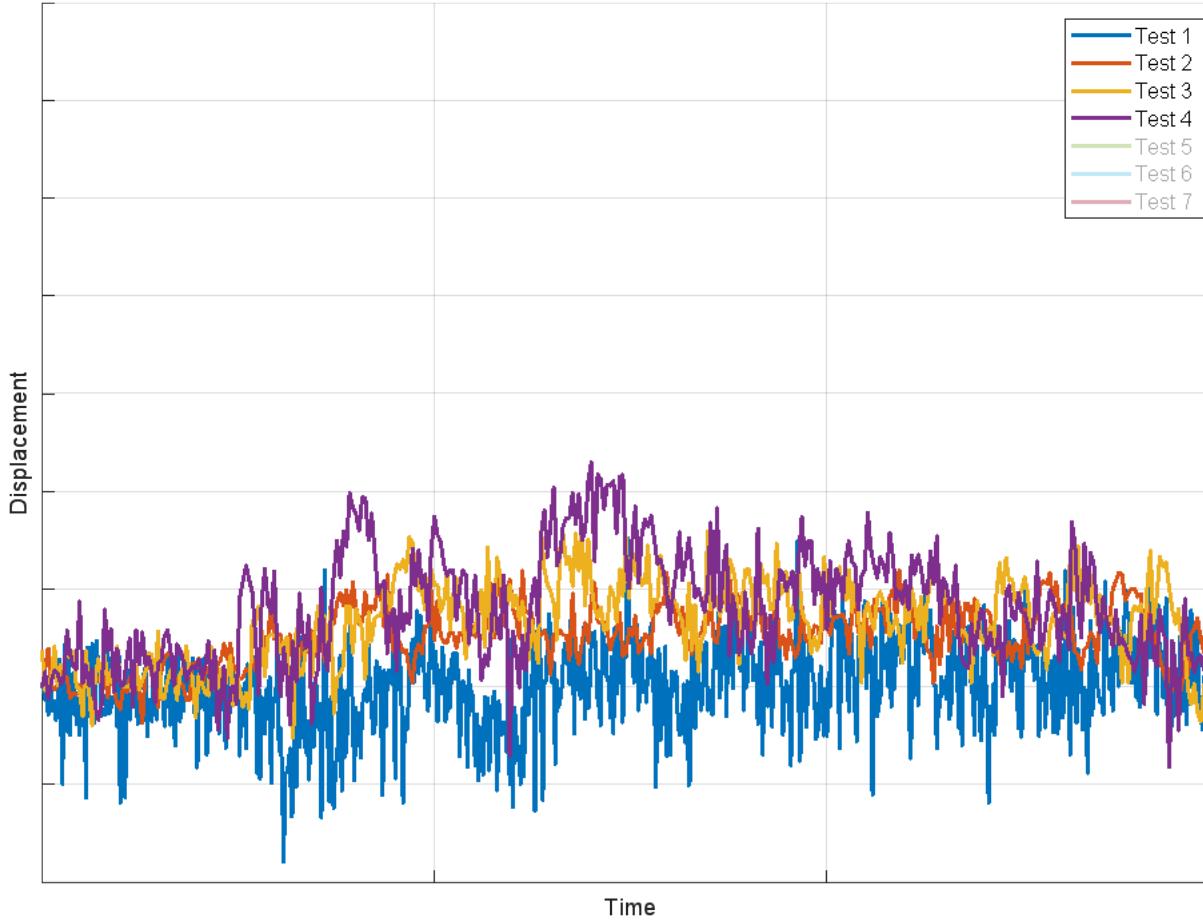
Shock Response Spectrum at Test Fixture



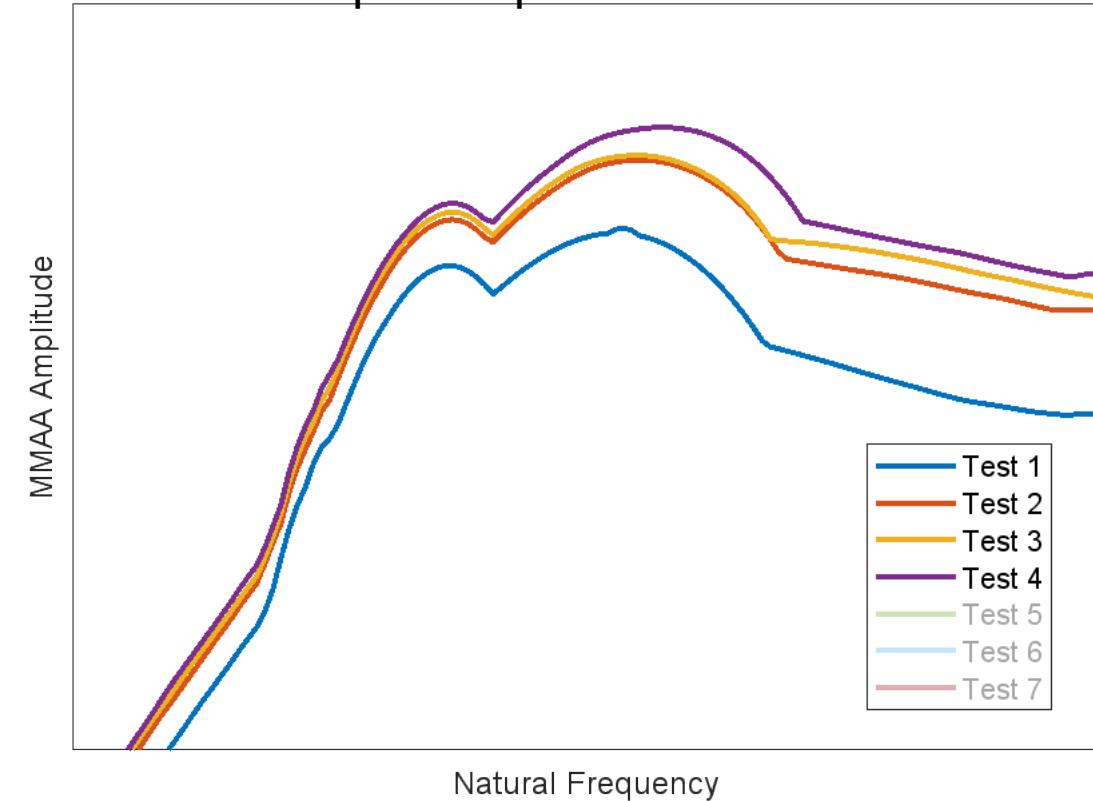
# Monitoring Displacements at Different Input Levels



Relative Motion Between Surfaces A & C



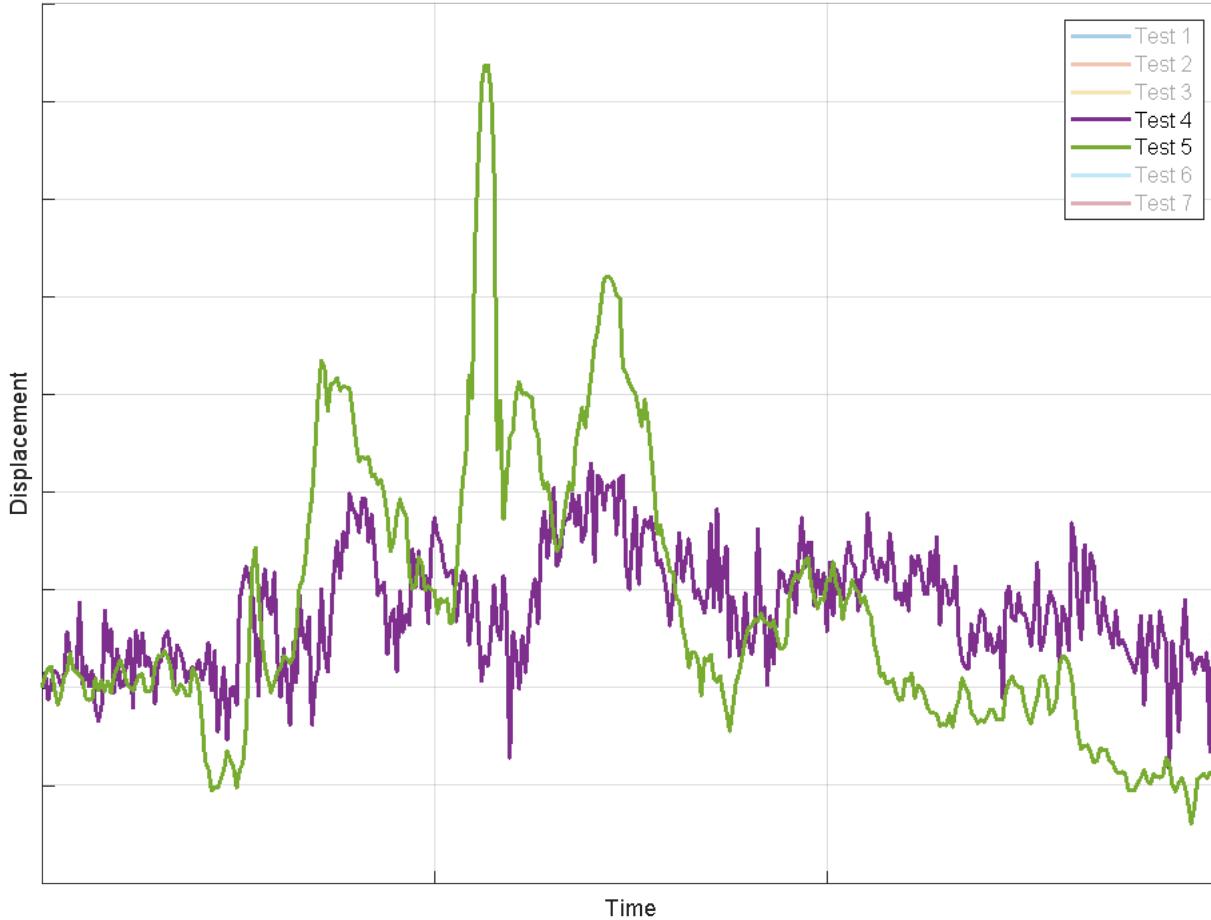
Shock Response Spectrum at Test Fixture



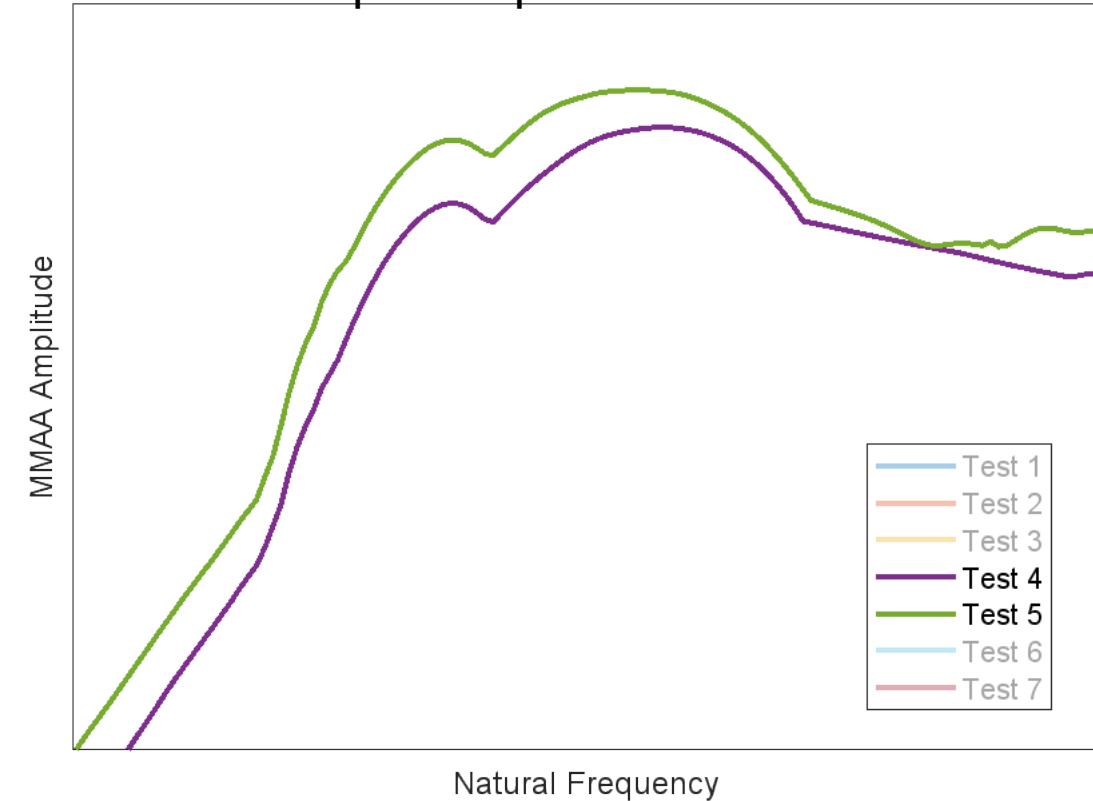
# Monitoring Displacements at Different Input Levels



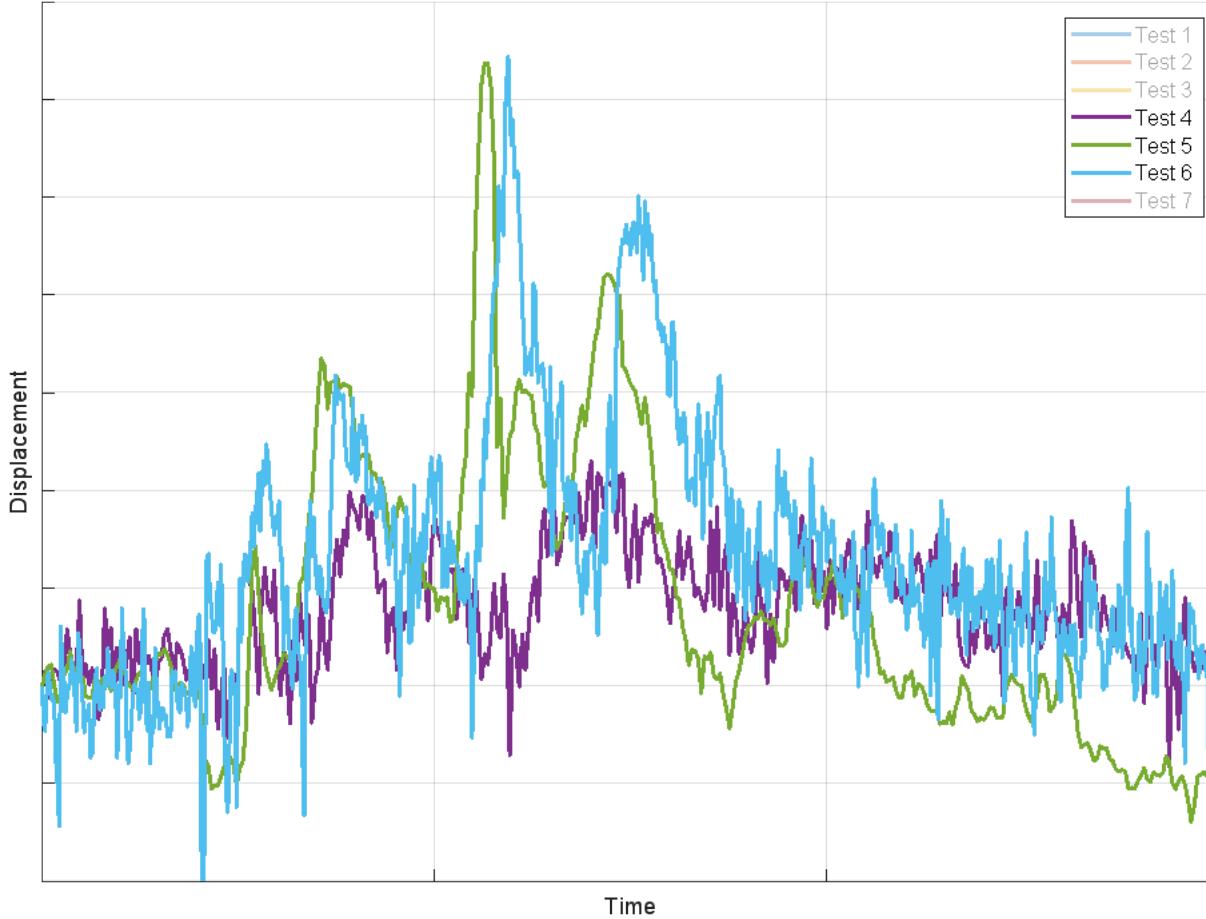
Relative Motion Between Surfaces A & C



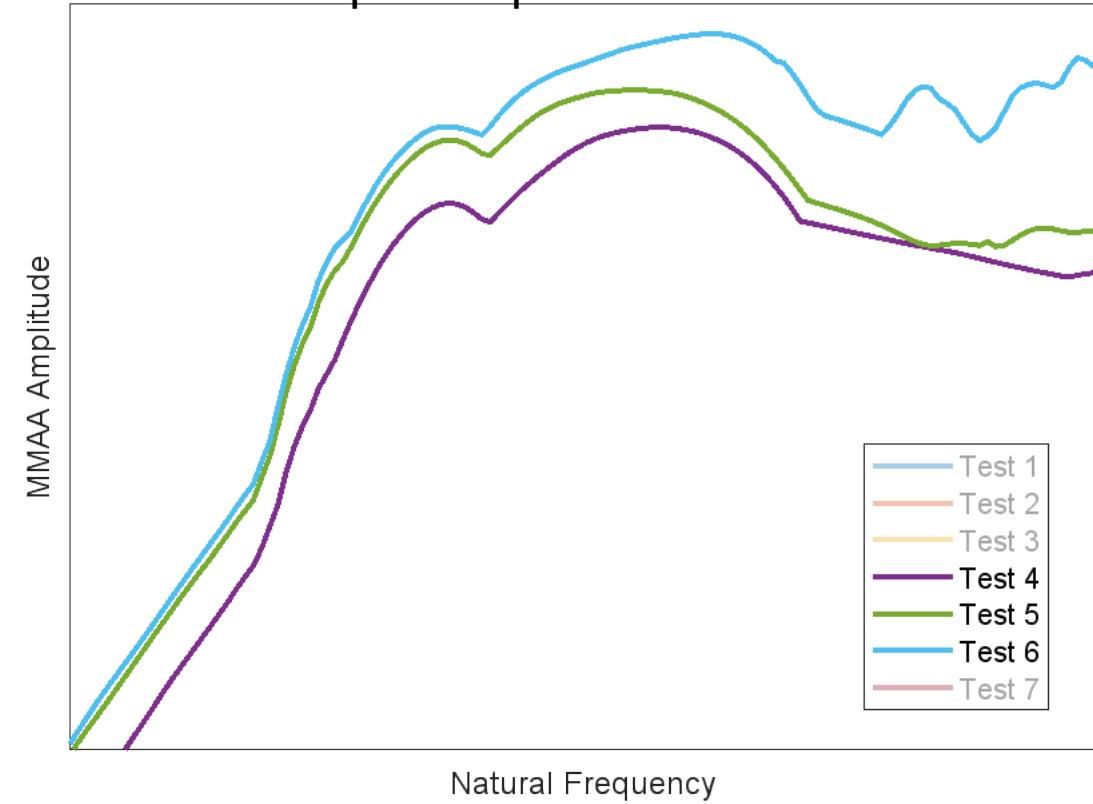
Shock Response Spectrum at Test Fixture



# Relative Motion Between Surfaces A & C



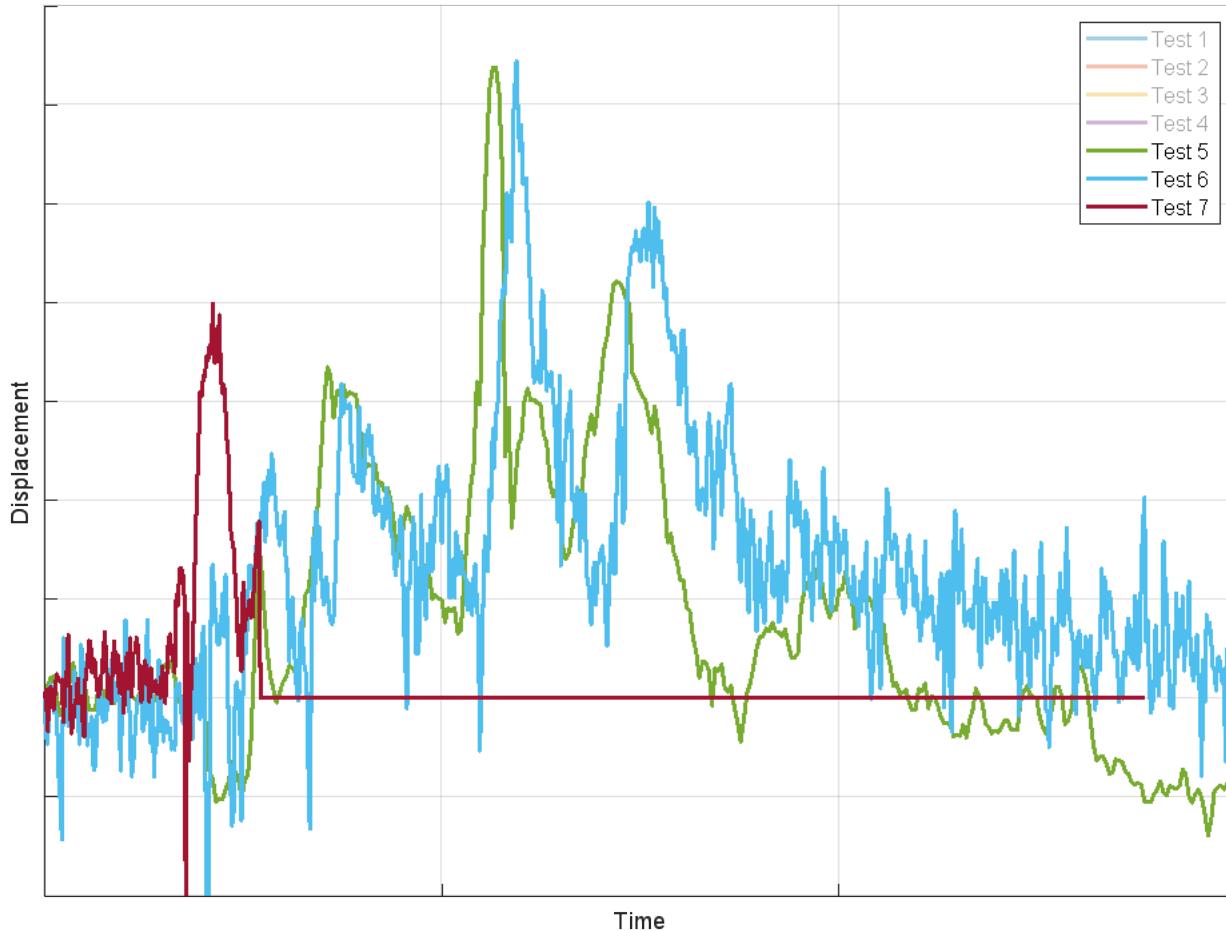
# Shock Response Spectrum at Test Fixture



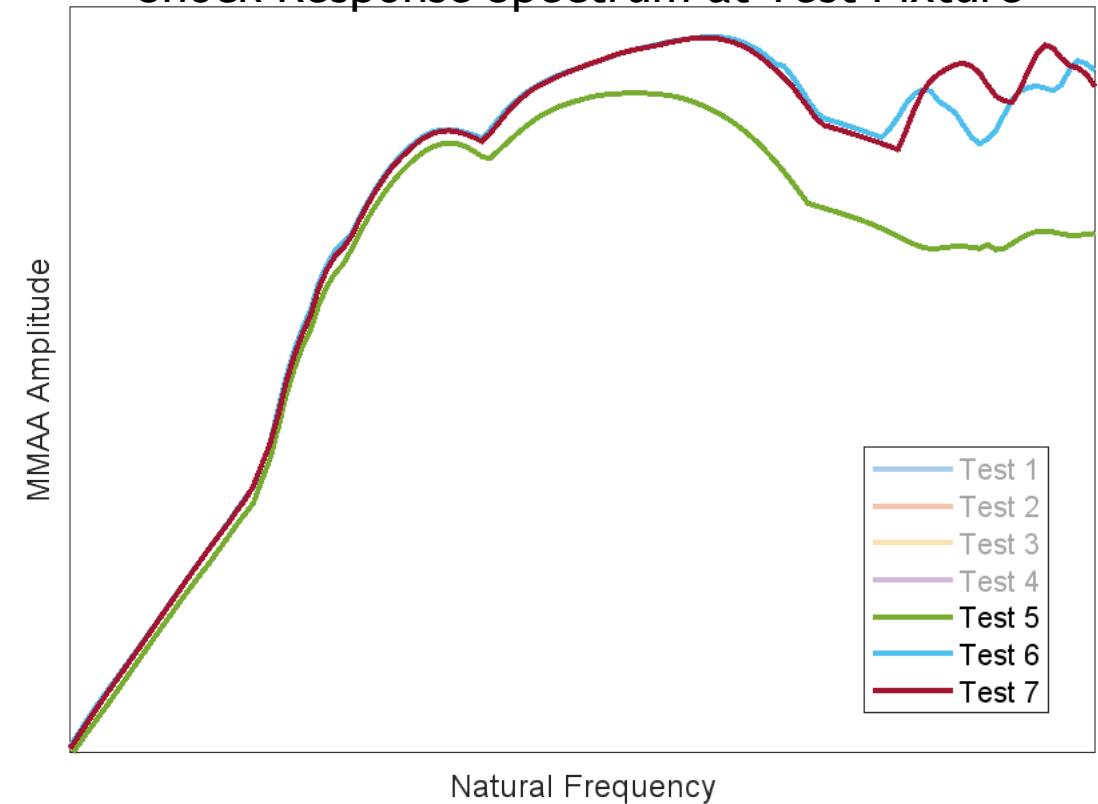
# Monitoring Displacements at Different Input Levels



Relative Motion Between Surfaces A & C



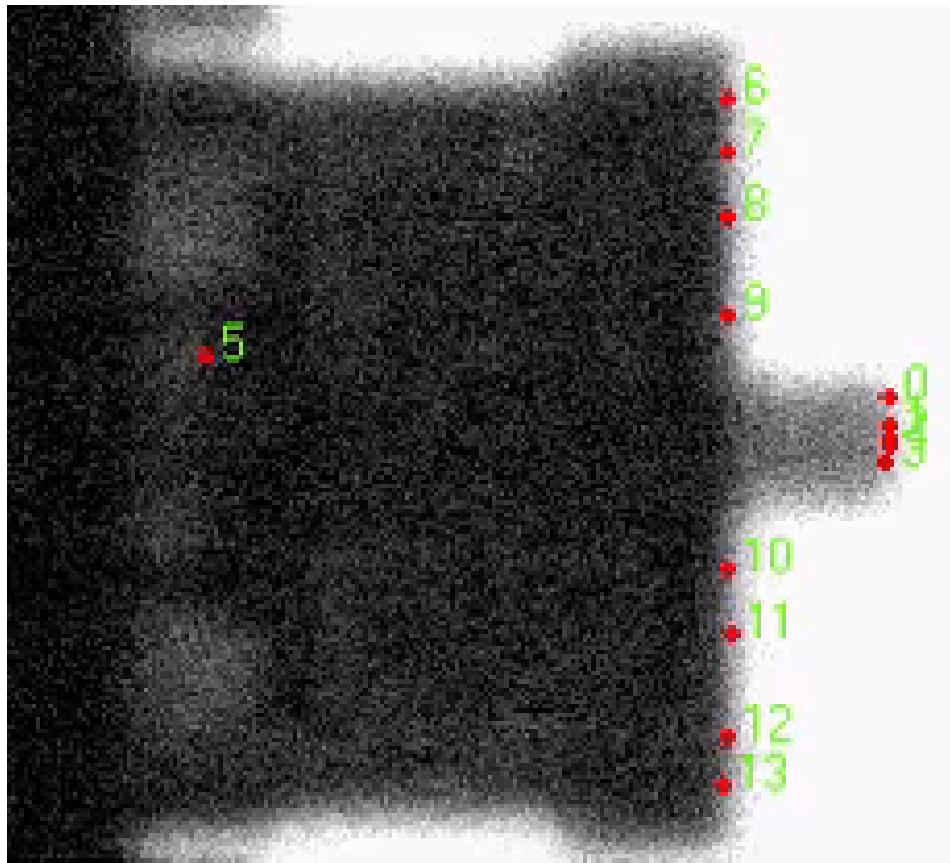
Shock Response Spectrum at Test Fixture



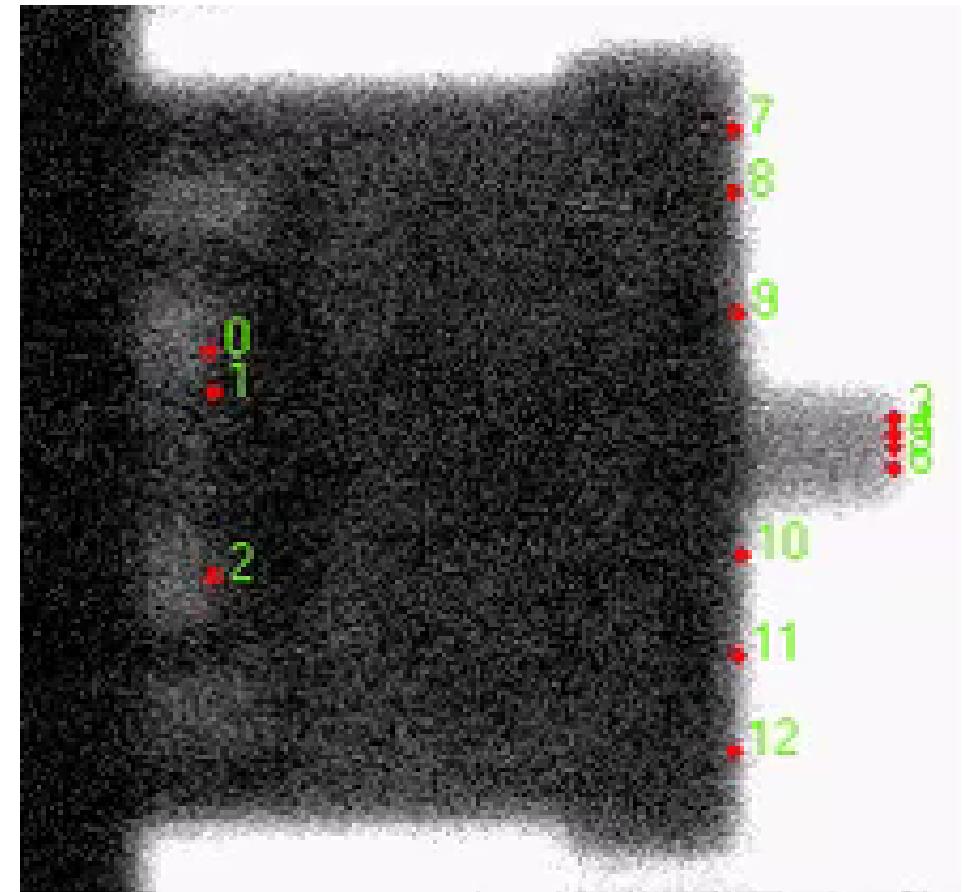
# Device Responses for Similar Input



Separation occurs in Test 7 (Watch points 0, 1, 2)



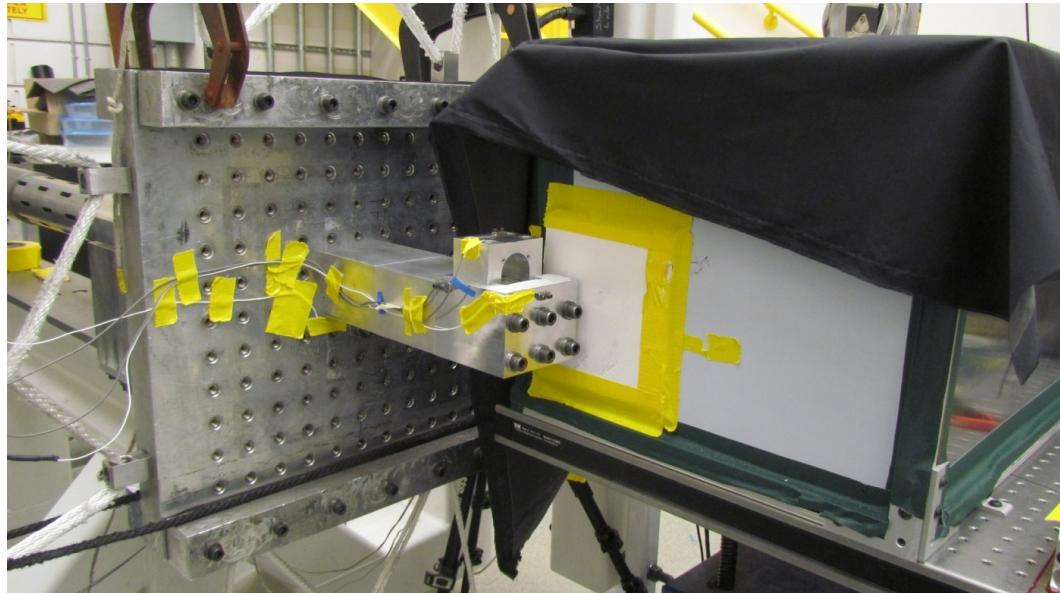
Test 6



Test 7

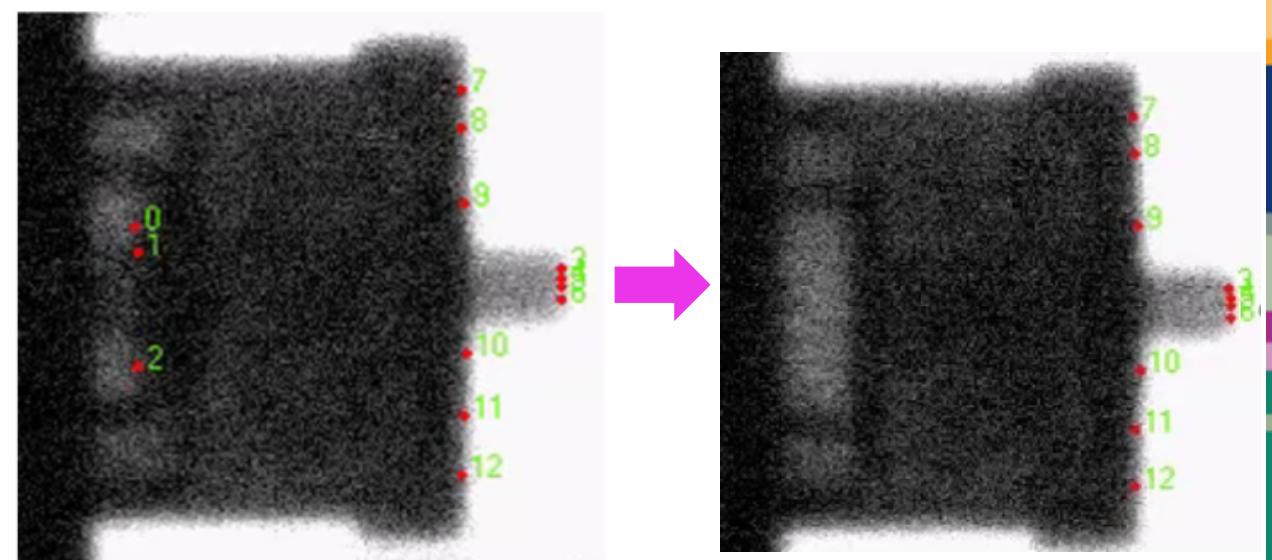
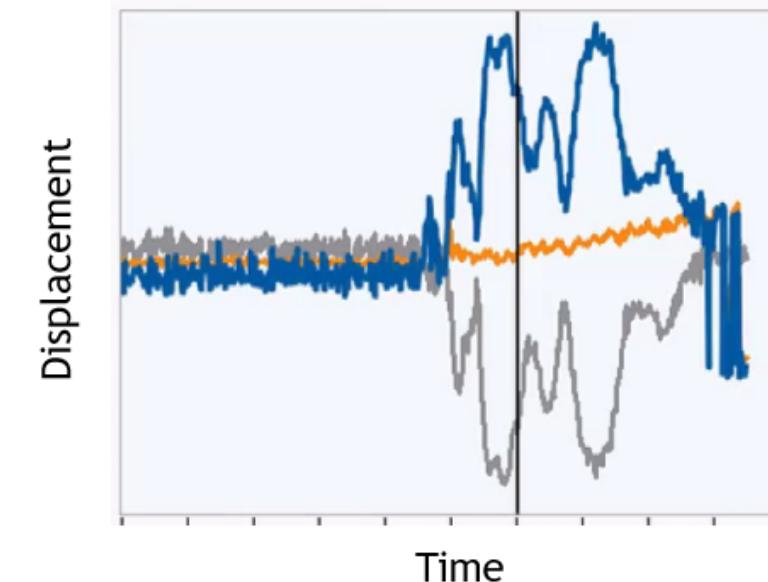
# Summary

A high-speed camera successfully capture x-ray images of a device under test



The relative displacement of two surfaces was quantified and increased with increasing SRS amplitude.

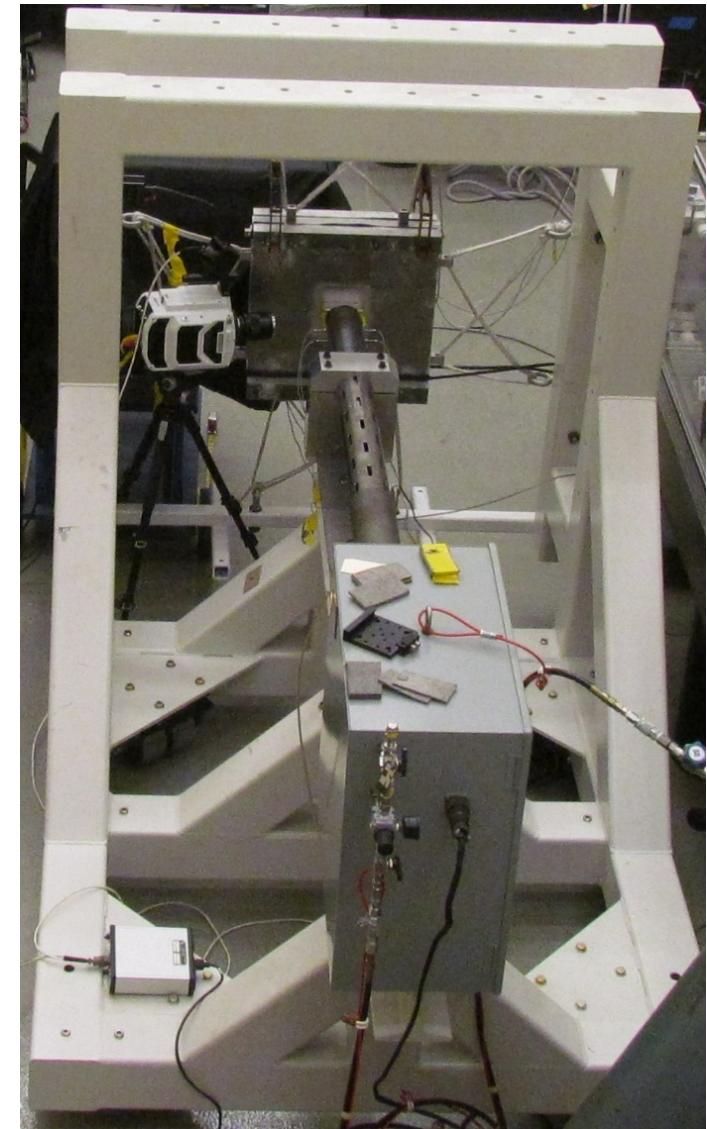
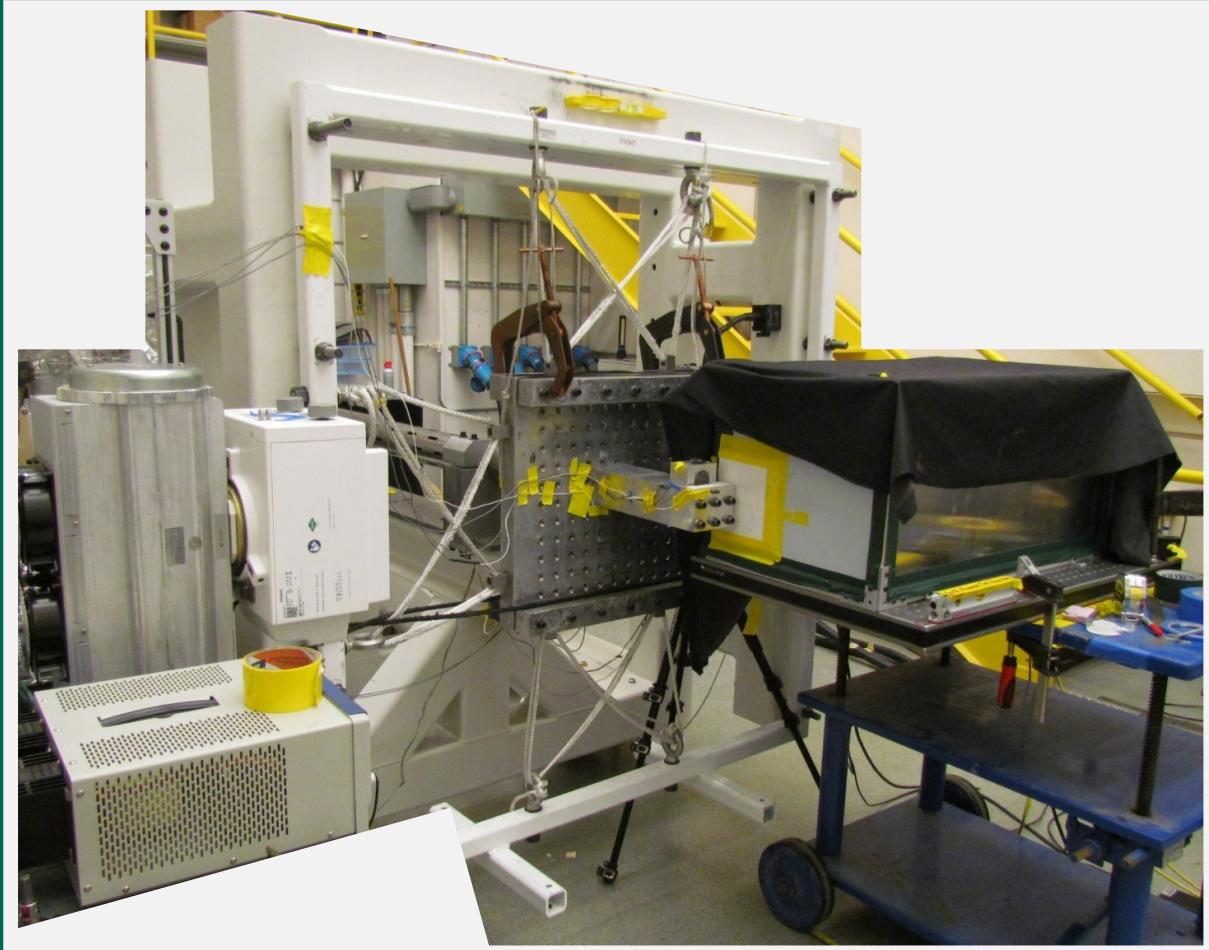
A threshold was identified at which the surfaces separated.



# Extra slides



# Test Setup



## All SRS Curves on Same Plot

